

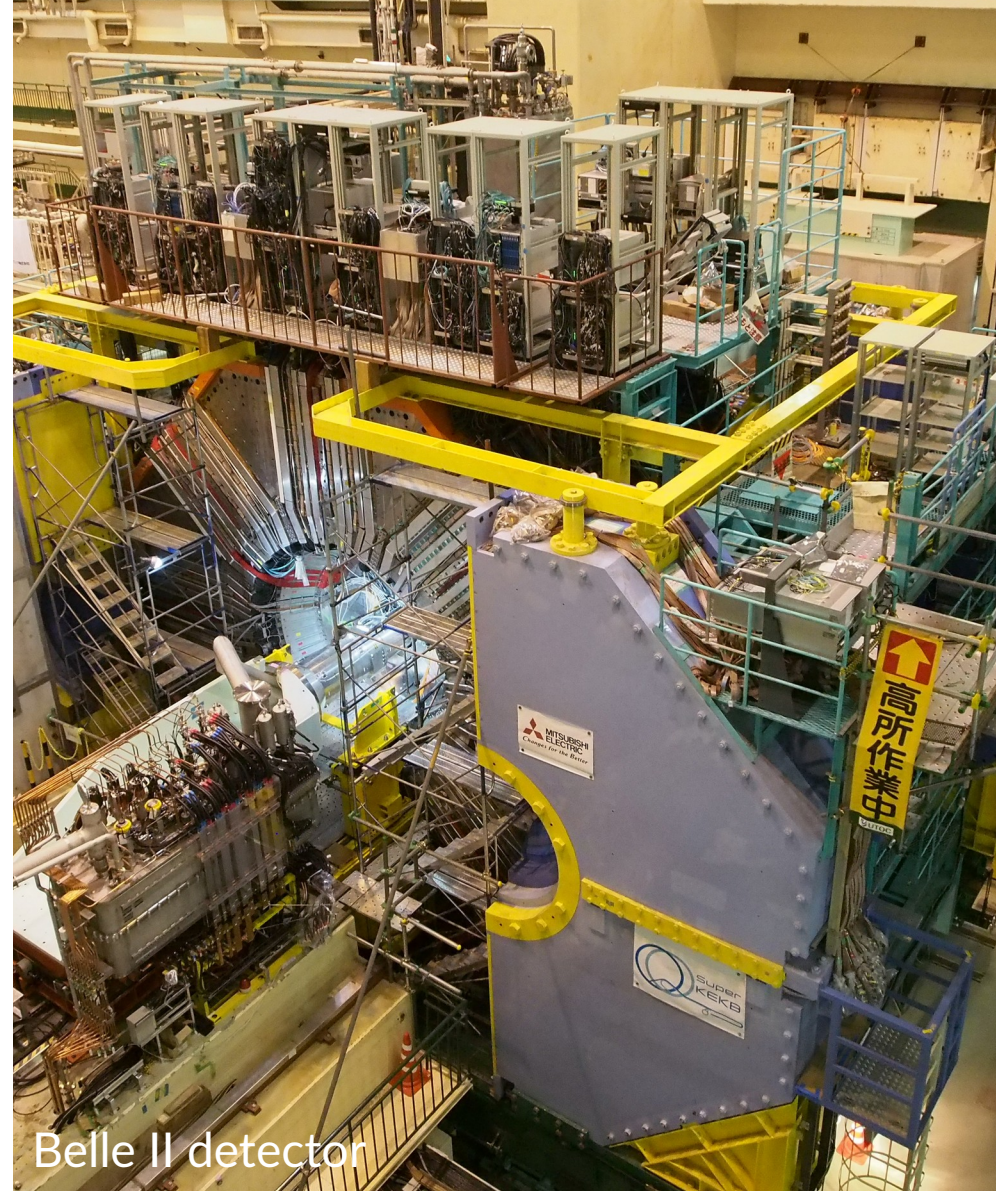
Hit time computed with the Silicon Vertex Detector (SVD) of Belle II

4D Track Reconstruction

May 8th, 2024, online

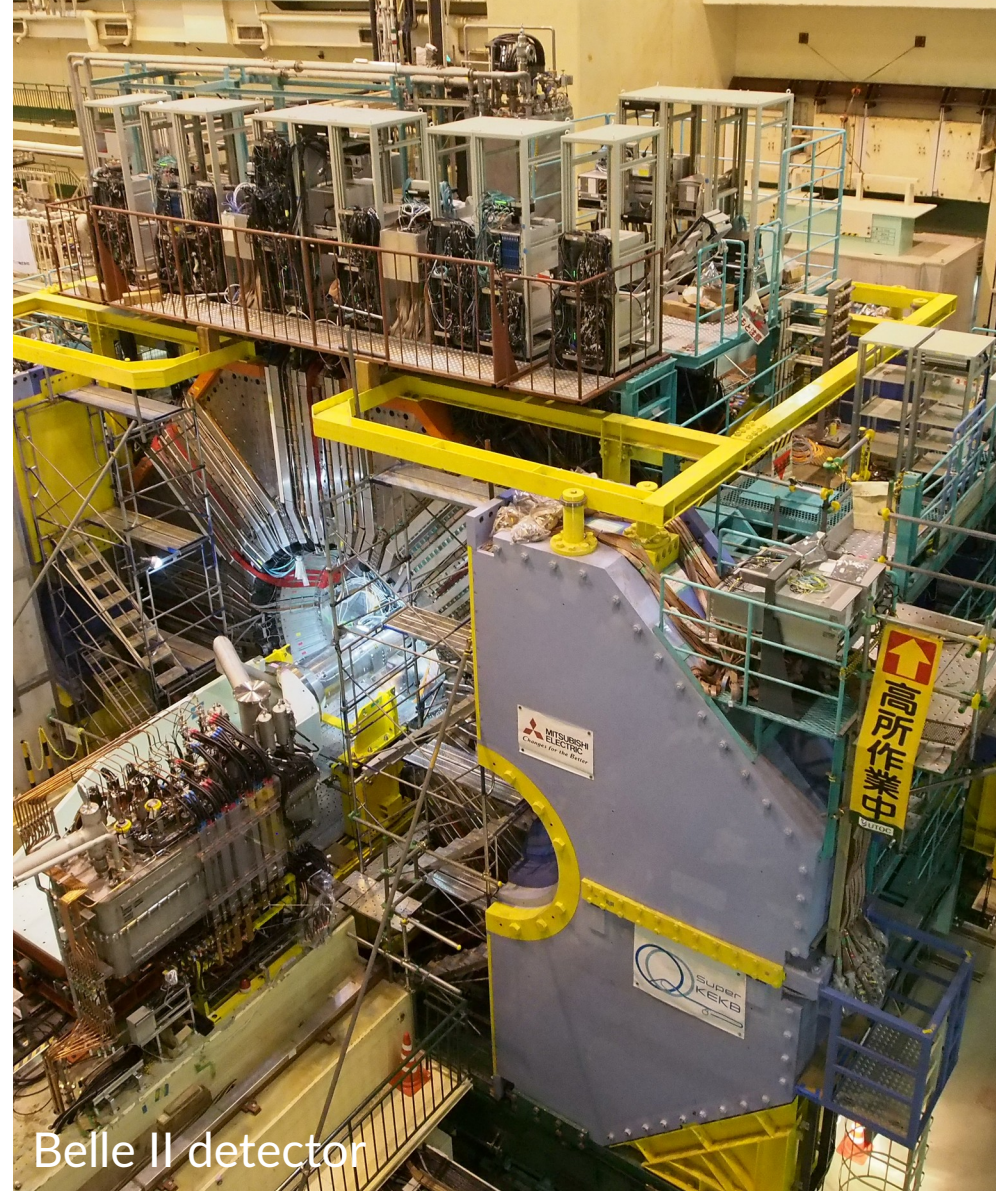
Outline

- Introduction to Belle II at SuperKEKB
- Introduction to SVD
- SVD time
- SVD time applications
- Conclusions



Belle II detector

Introduction to Belle II

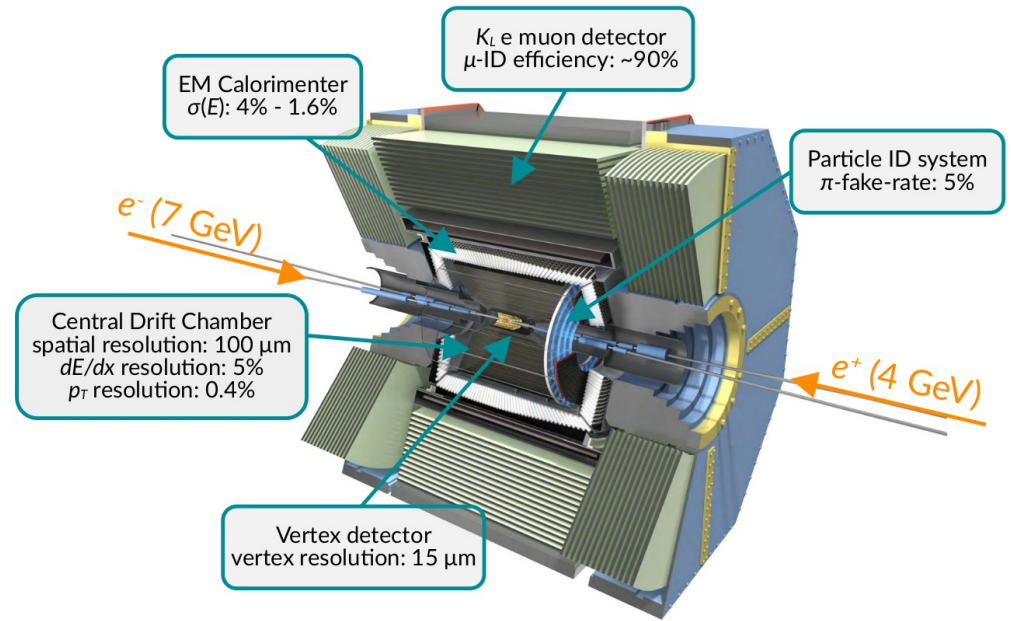
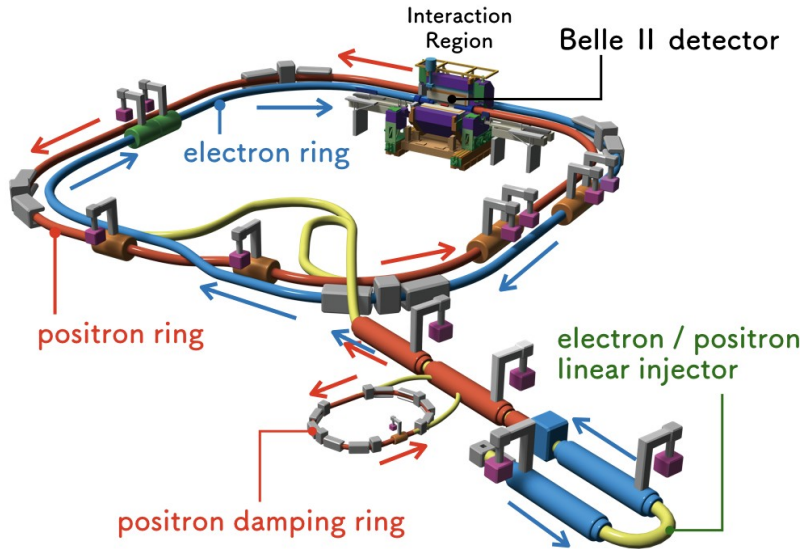


Belle II detector

Belle II at SuperKEKB

SuperKEKB

- **Asymmetric e^+e^- collider** operated at $\sqrt{s} = 10.58 \text{ GeV}$ [Y(4S)]
- **Well know initial-state condition and low multiplicity environment**



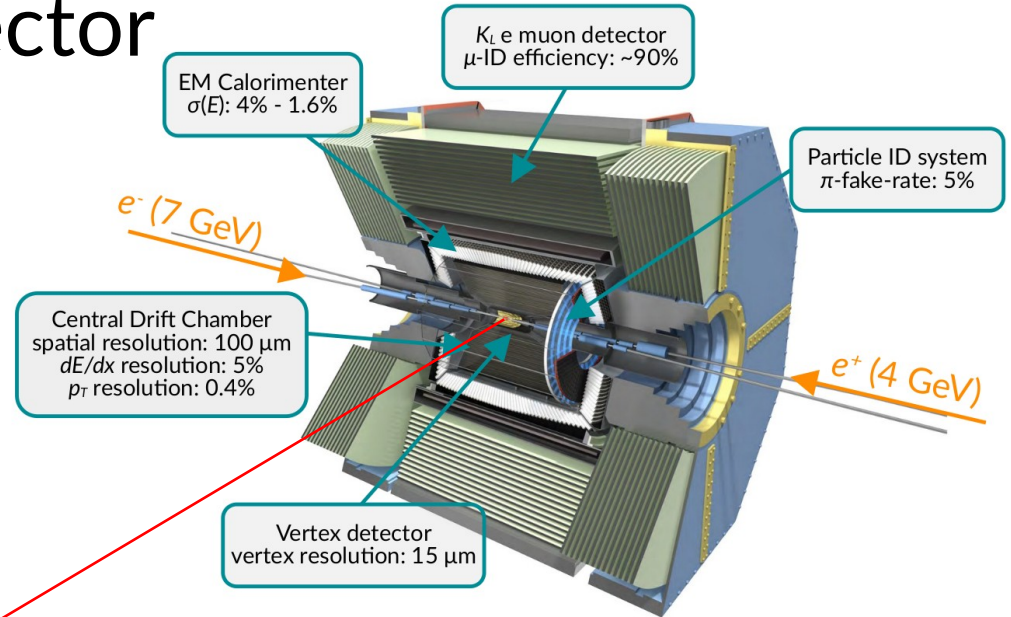
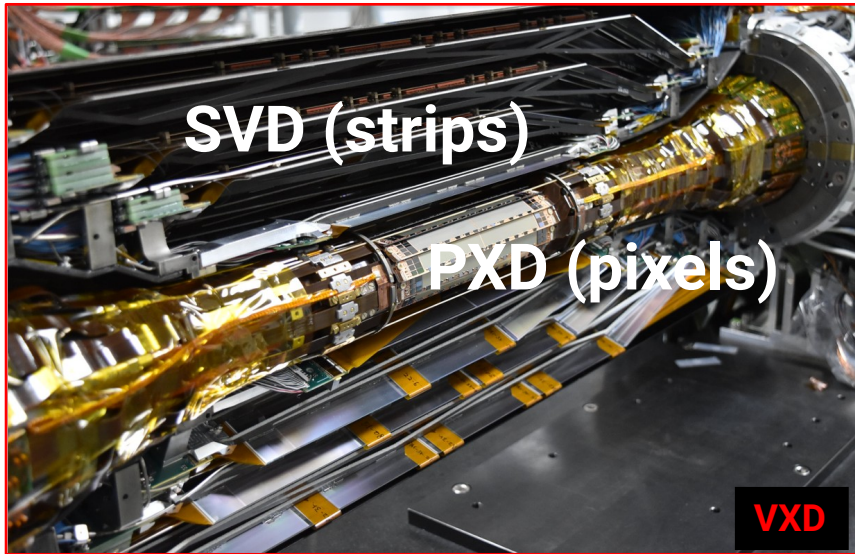
Belle II

- **Hermetic detector with high performances** (upgrade of Belle at KEKB)
- **Run1 (2019-2022) $\rightarrow 424 \text{ fb}^{-1}$, Run2 just started**
- **Dedicated low-multiplicity trigger \rightarrow Belle II dataset unique**

The Belle II Vertex Detector

Vertex detector (VXD)

- Provide the precise measurement of the primary and secondary vertices of short-lived particles

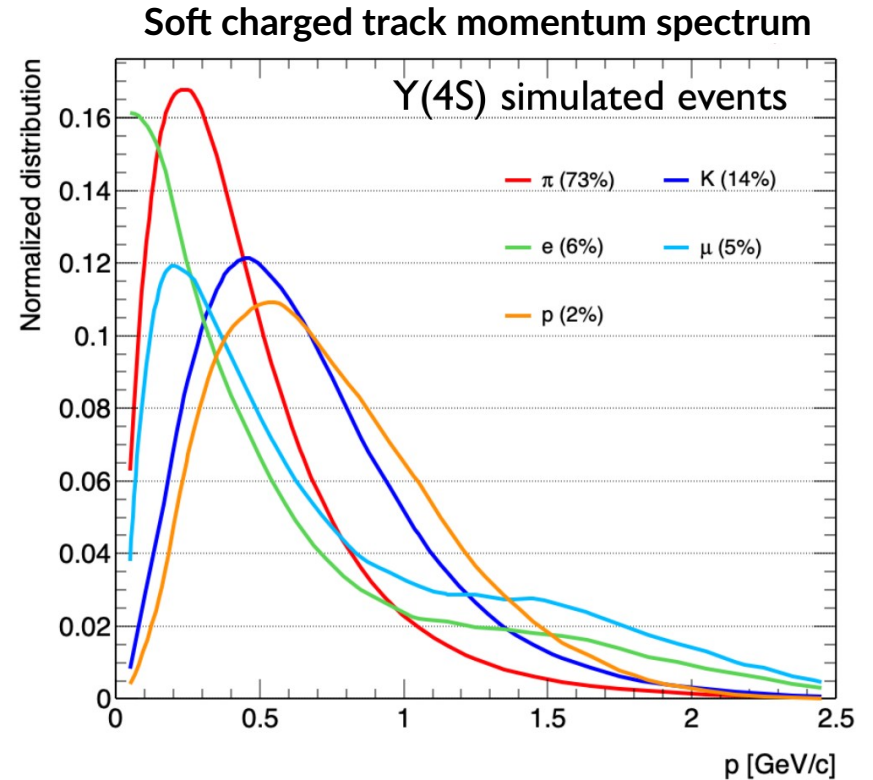


VXD detectors

- Pixel Detector (PXD): 2-layer DEPFET pixel sensors
- Silicon Vertex Detector (SVD): 4-layer Double-Sided silicon Strip Detector
- Position of layers: 1.4 cm, 2.0 cm, 3.9 cm, 8.0 cm, 10.4 cm, 13.5 cm

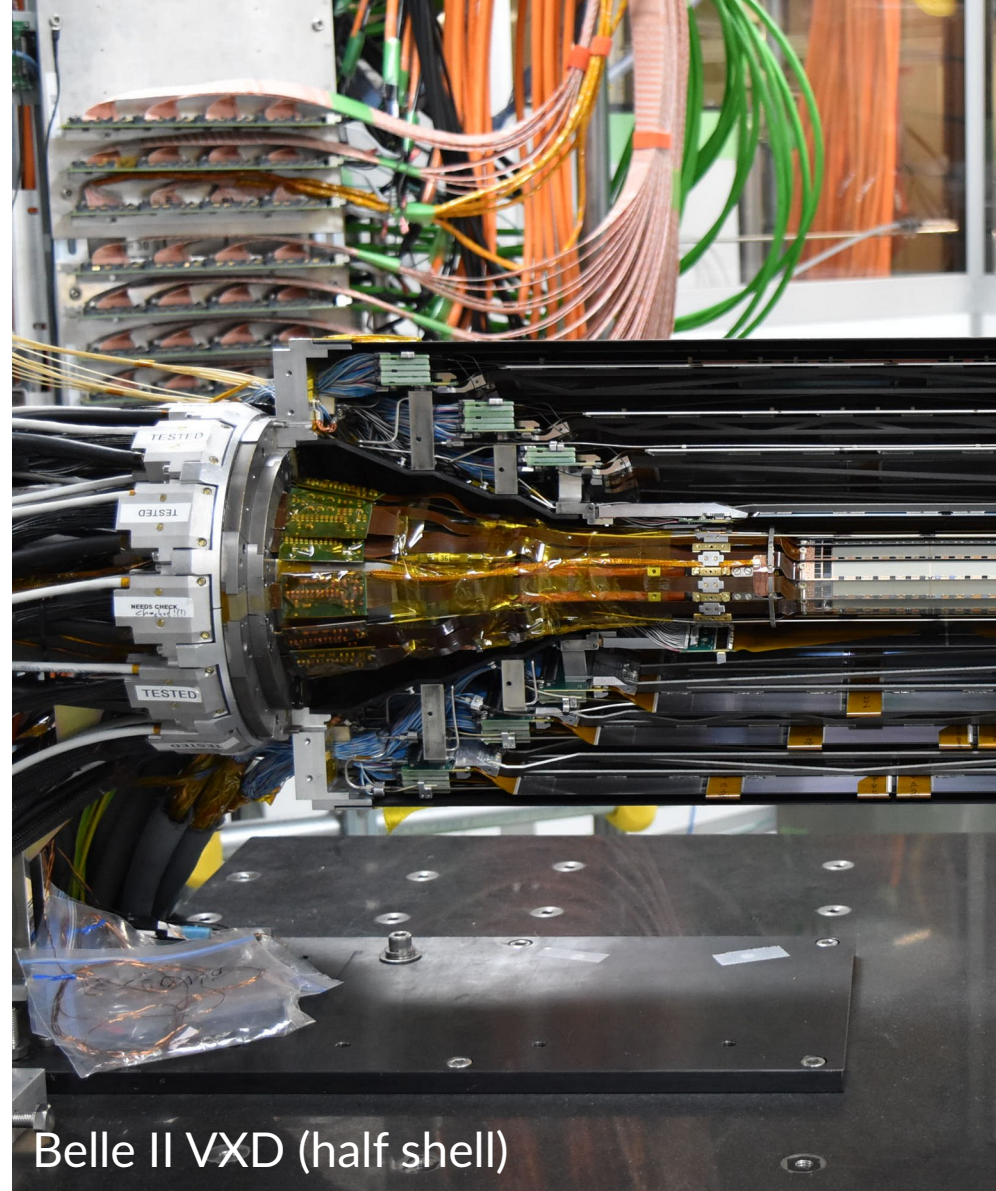
Typical event at Belle II

- Average multiplicity in a Y(4S) event
 - 11 charged tracks
 - 5 neutral pions
 - 1 neutral kaon
- Few tracks with small momentum to reconstruct
 - They are significantly affected by multiple scattering
- Signal hits in VXD are overwhelmed by beam-background hits
- SuperKEKB nominal luminosity: $6 \times 10^{35} \text{ cm}^{-2} \text{ s}^{-1}$



S.KEKB nominal luminosity	Layer 1 of pixels		Layer 3 of strips	
	Number of hits	Occupancy	Number of hits	Occupancy
Y(4S)	11	$5 \cdot 10^{-6}$	11	0.2%
beam bkg	50000	3%	3200	3%

Introduction to SVD



Belle II VXD (half shell)

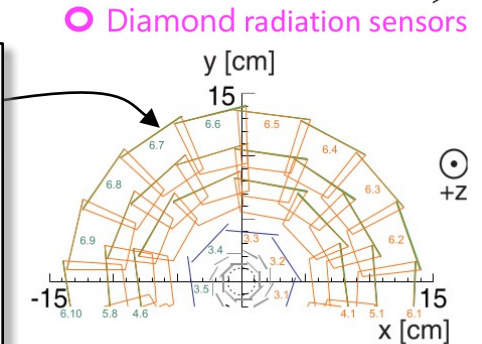
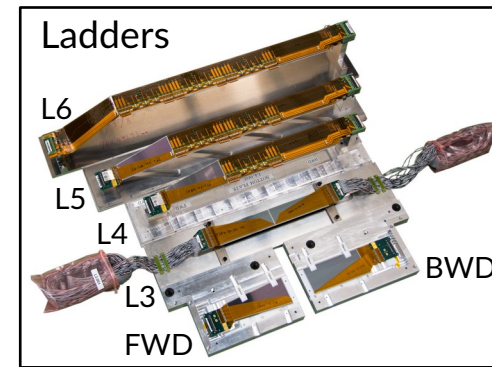
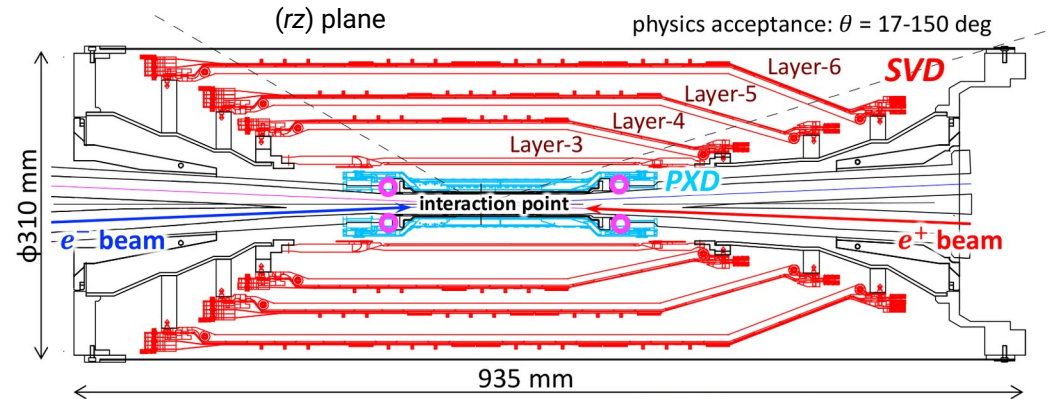
Silicon Vertex Detector (SVD)

SVD structure:

- 172 sensors, 1.2 m² of sensitive area, 224k readout strips → grouped into ladders
- Slanted forward sensors → maximize acceptance with smaller incidence angle
- Low material budget of 0.7% X₀/layer
- Diamond sensors for radiation monitor and beam abort

Main SVD functions:

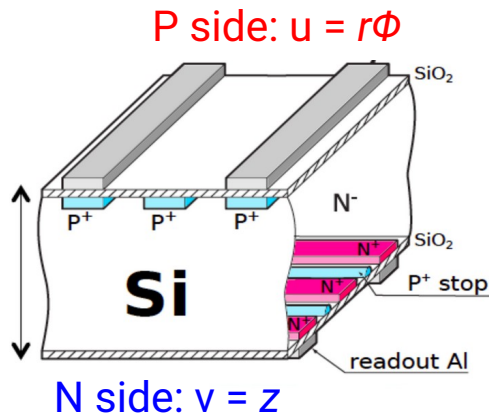
- Standalone tracking for low p_T tracks
- Extrapolate tracks to PXD
- Precise and efficient vertexing of K_S
- Provide particle identification with dE/dx



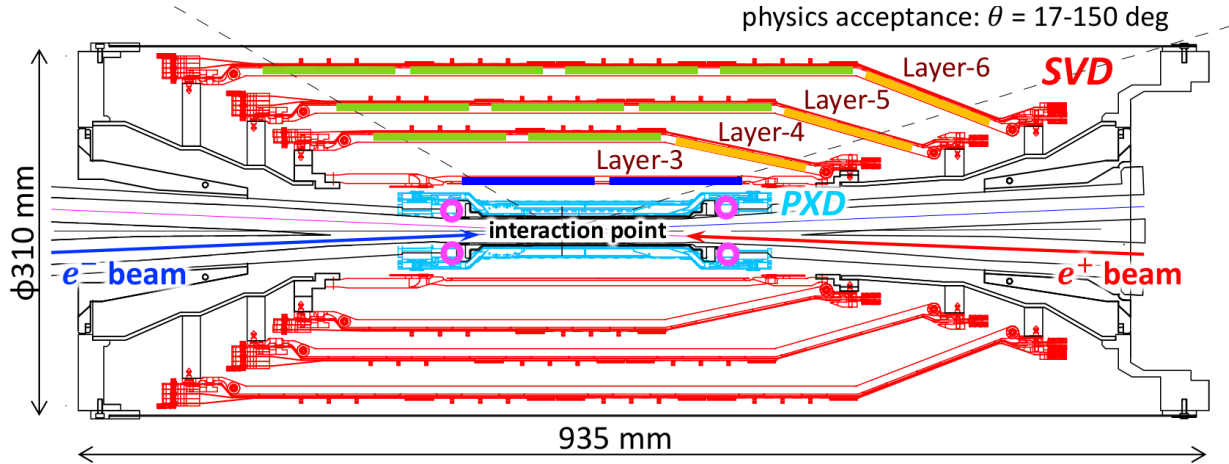
Layer	Ladder/Layer	Sensor/Ladder	Slant angle
3	7	2	0°
4	10	3	11.9°
5	12	4	17.2°
6	16	5	21.1°

SVD sensors

- Double-Sided Strip Detector (DSSD)
 - Provide 2D spatial information



- Sensor thickness: 300–320 μm
- Depletion voltage: 20–60 V
- Operation voltage: 100 V

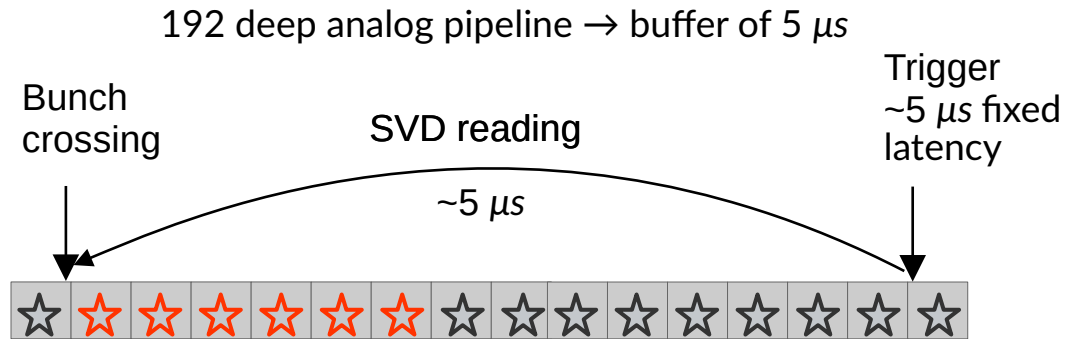


	<u>Small sensors</u>	<u>Large sensors</u>	<u>Trapezoidal sensors</u>
Readout strips <i>P</i> -side	768	768	768
Readout strips <i>N</i> -side	768	512	512
Readout pitch <i>P</i> -side	50 μm	75 μm	50 – 75 μm
Readout pitch <i>N</i> -side	160 μm	240 μm	240 μm
Sensor active area (mm^2)	122.90×38.55	122.90×57.72	$122.76 \times (38.42 - 57.59)$
Sensor thickness	320 μm	320 μm	300 μm
Manufacturer	Hamamatsu	Hamamatsu	Micron

SVD readout system

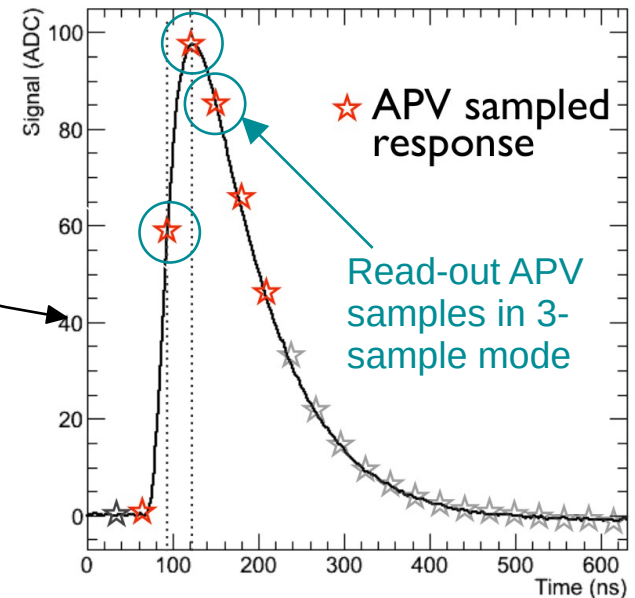
Front-end ASIC: APV25 chip

- Radiation hardness > 100 Mrad
- Shaping time of 50 ns
- 128 channel inputs
- Operated in multi-peak mode at 32 MHz
 - Collision frequency 256 MHz and clock not synchronous with collisions
 - 6 samples recorded, 3/6 samples in future to reduce data size
- Physics events are triggered at maximum 30kHz

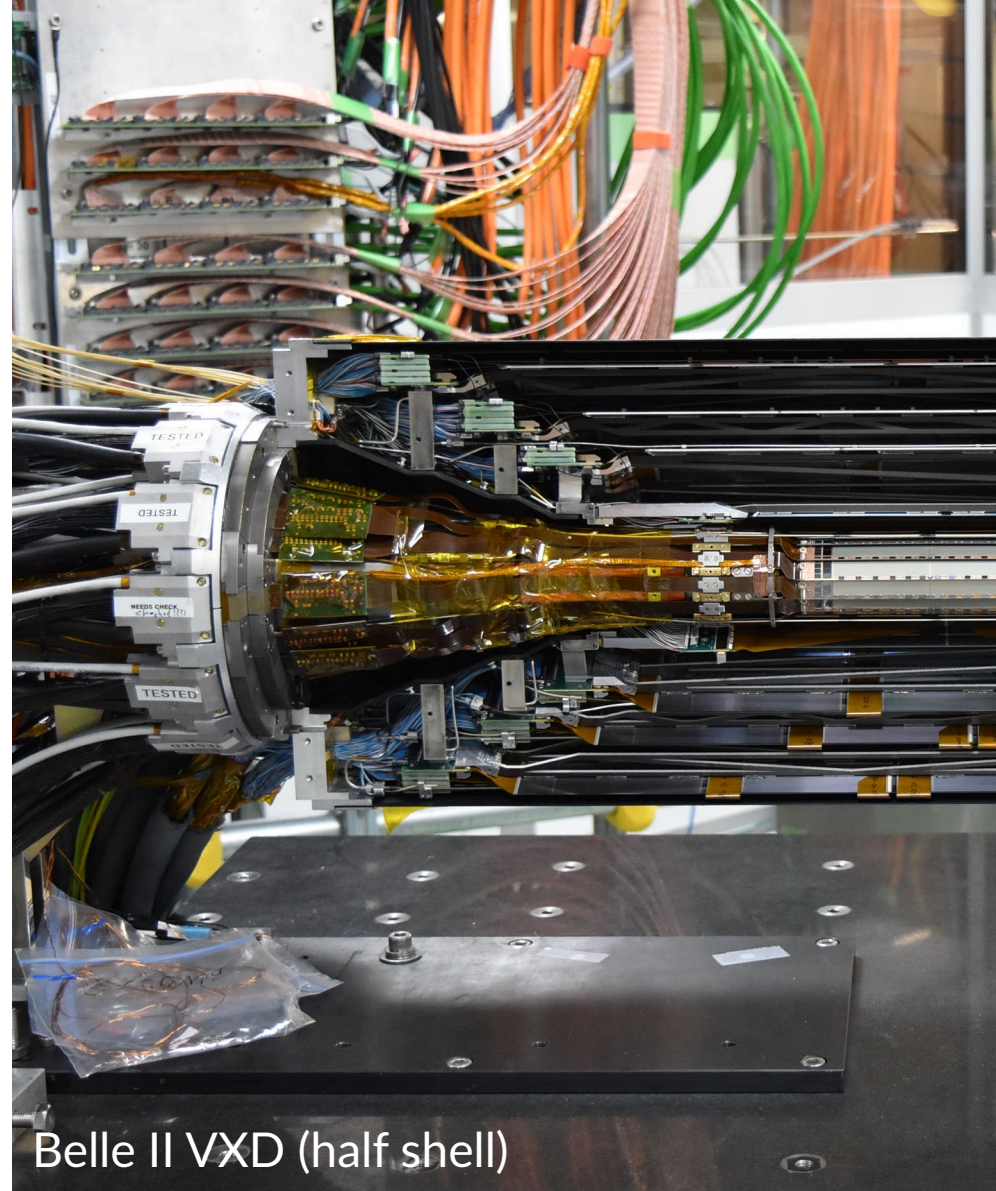


6 samples
acquired

APV25 sampling output



SVD Hit Time



Belle II VXD (half shell)

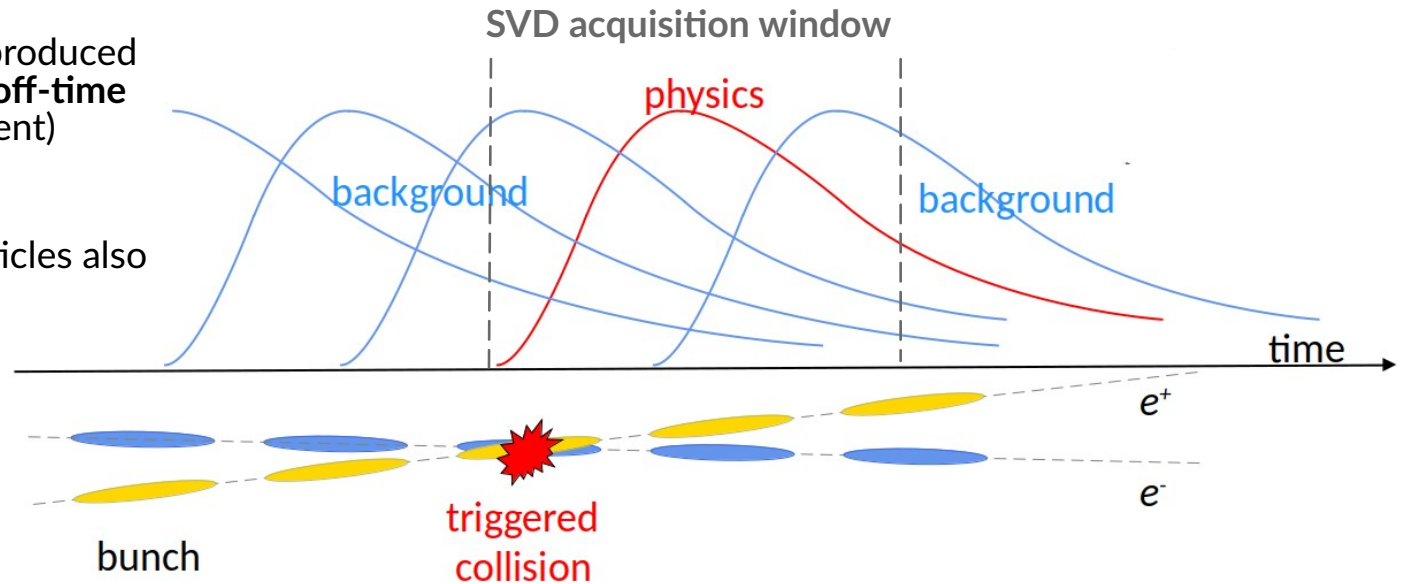
SVD hit time

- Precise determination of the **SVD hit time** is crucial to significantly reduce the occupancy by rejecting off-time particles
- Physics events are triggered at maximum 30kHz, while the frequency of bunch crossing is 256 MHz

→ In each bunch-crossings are produced **beam-background particles** (off-time with respect the triggered event)

→ Single-beam background particles also hitting SVD sensors

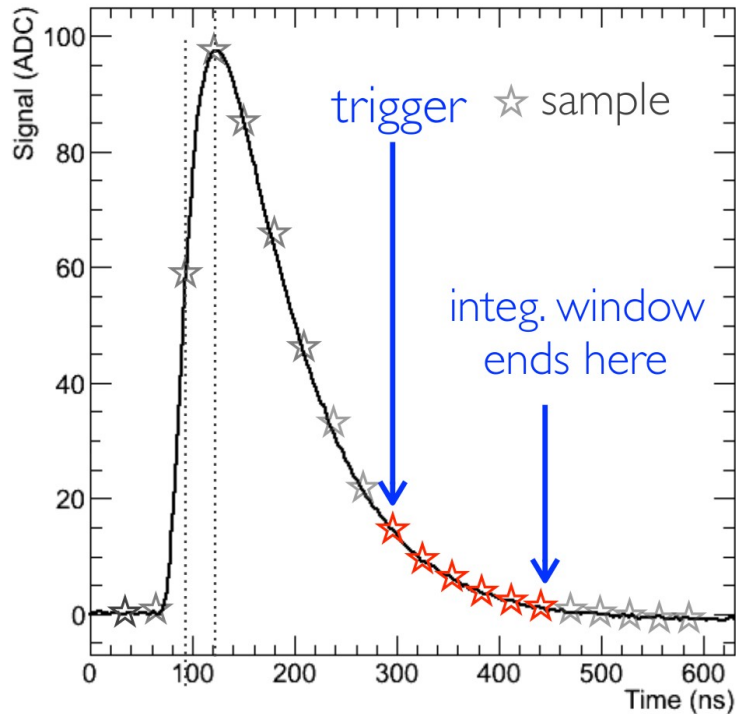
→ The signals of those particles stays over threshold for several bunch crossings



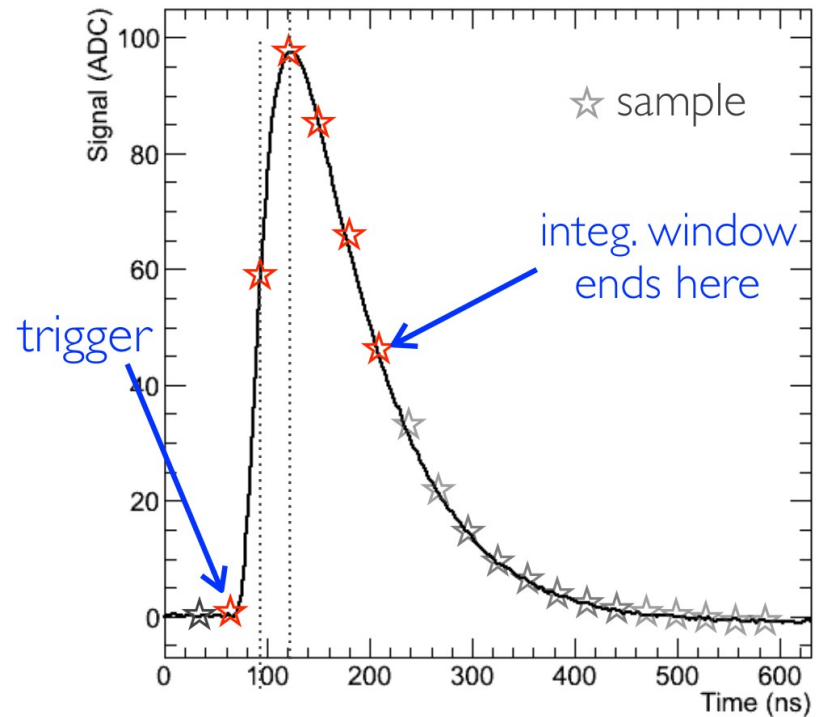
Off-time and on-time particle signals

- SVD hit time determined using the sampling of the signal response and the information of the trigger arrival

OFF-time particle noiseless response



ON-time particle noiseless response



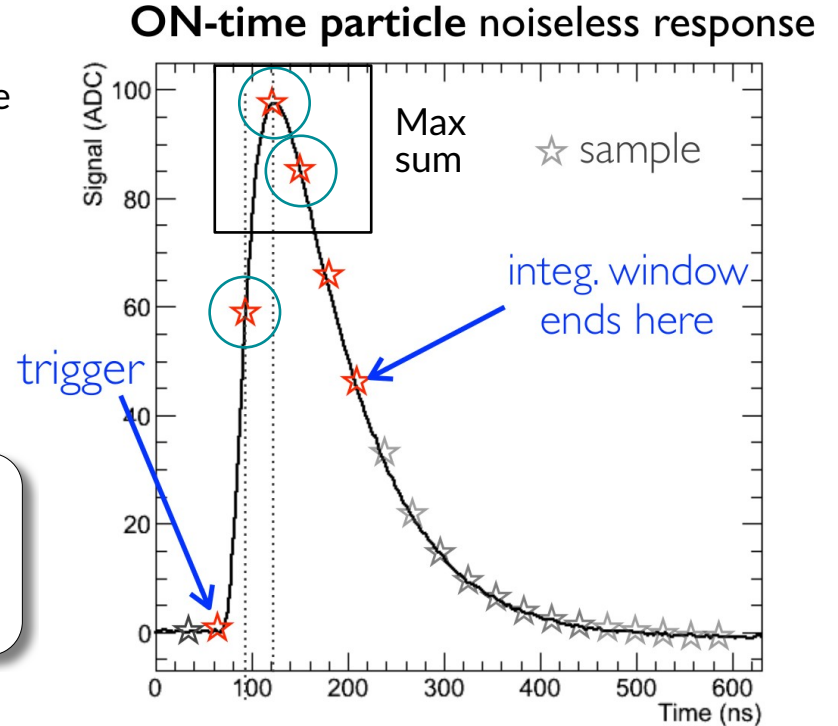
SVD hit time computation

- Default algorithm in reconstruction:
 - Sum the SVD cluster strips → a **single strip** where the amplitude of the 6 samples is the sum of the amplitudes of the samples of the strips
 - Find the best three samples and take the **weighted average**
 - ▶ Max sum of samples taken 2-by-2 + the sample before

$$t_{hit} = \frac{\sum_n t_n \cdot A_n}{\sum_n A_n}$$

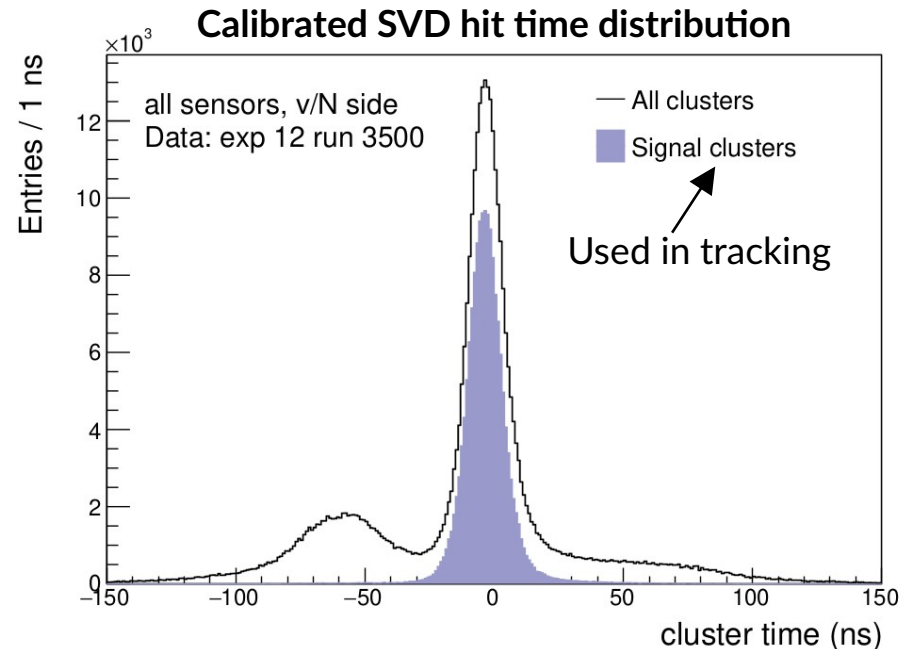
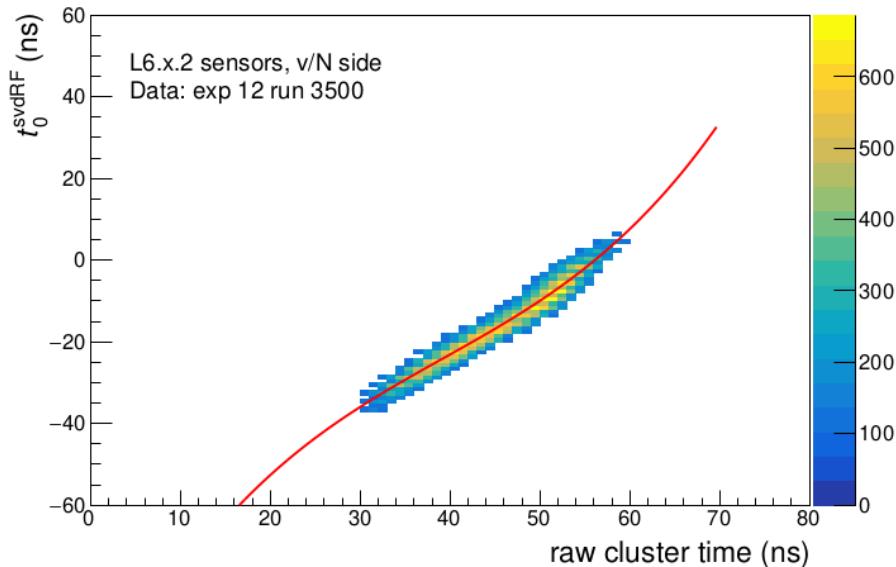
n : sample
 A_n : amplitude of the sample
 t_n : time of the sample

- Estimate the position of the peak in the SVD reference frame ($t=0$ at first sample)



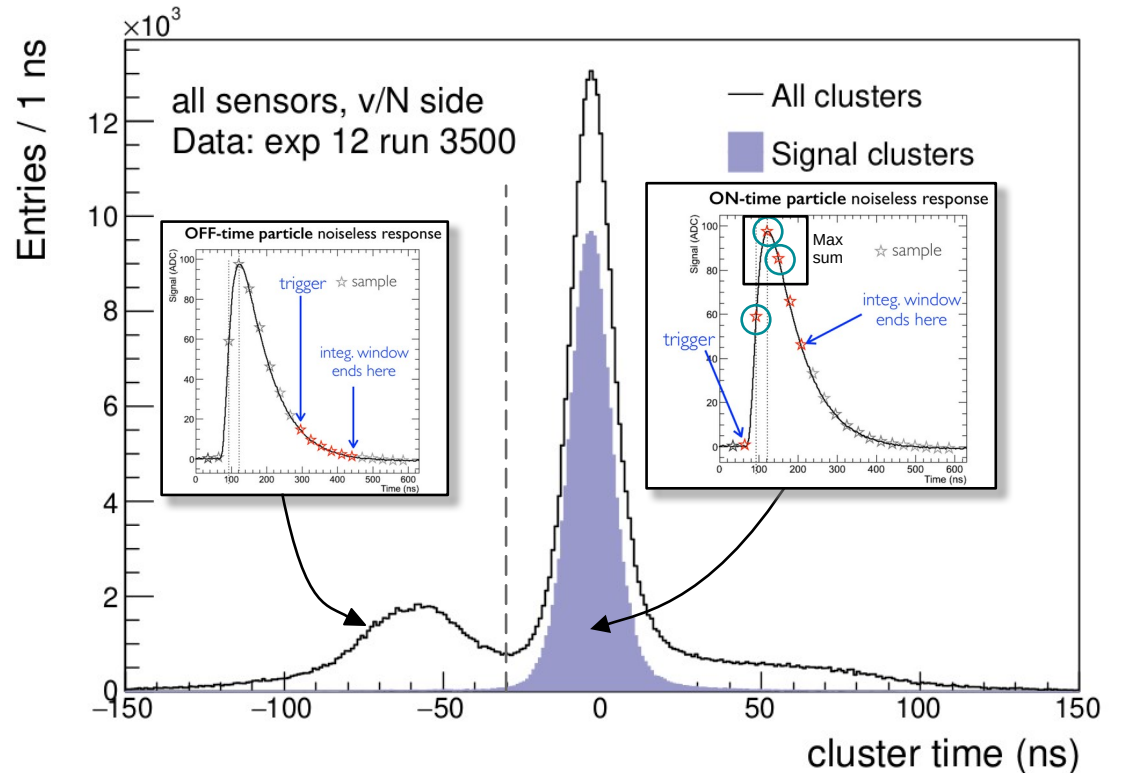
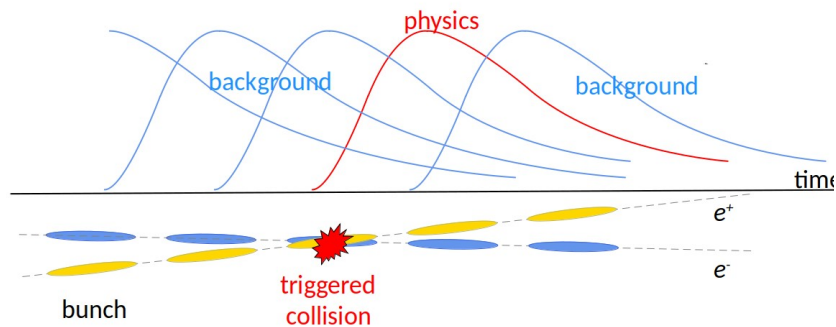
Hit time calibration

- Use CDC Event Time to calibrate SVD Time → from SVD reference frame to trigger reference frame
 - CDC and SVD times are not synchronized → we exploit the info about **trigger arrival to synchronize them**
 - Exploit the **correlation between CDC and SVD** times to calibrate SVD time → fit with a polynomial function
 - **Performed sensor/side-by-sensor/side**



Calibrated SVD time

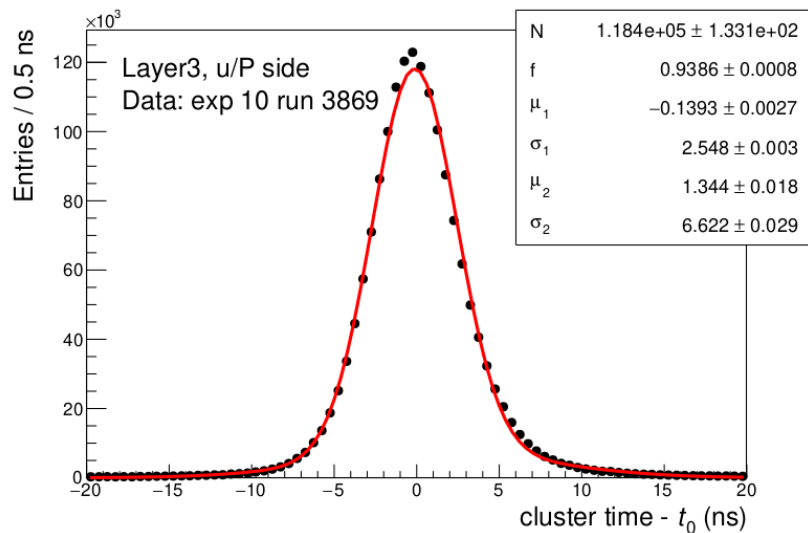
- Peak below < 50 ns: accumulation of off-time particles hitting the sensor before the beginning of the acquisition window
- The rest of the background hits are more uniformly distributed in time
 - Bunch crossing at 256MHz → quasi-continuous machine
 - Single-beam background particles out of collisions



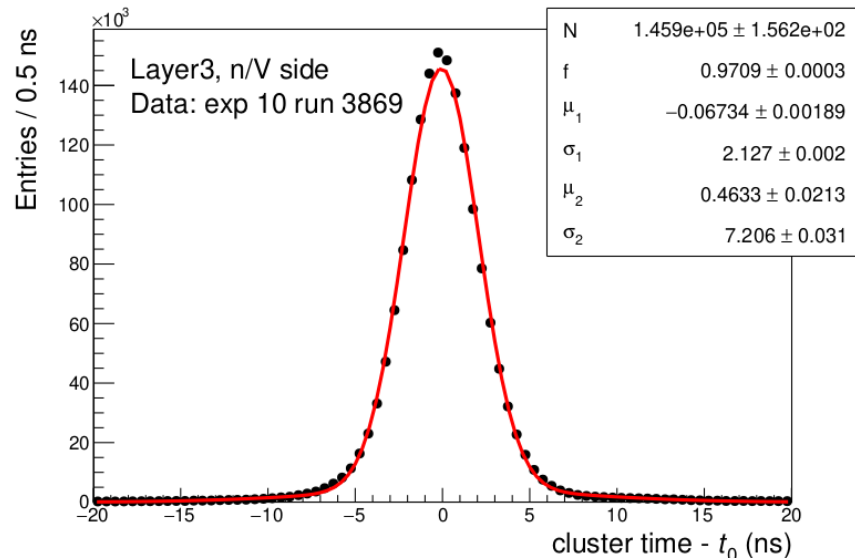
Calibrated SVD time: resolution

- Resolution is smaller than 3 ns in L3 in both SVD sides → Can be used to reject off-time hits, estimate Event Time and Track Time
- Excellent hit time resolution allows efficient removal of off-time tracks
 - Efficient to remove 50% off-time hits, keeping 99% signal efficiency

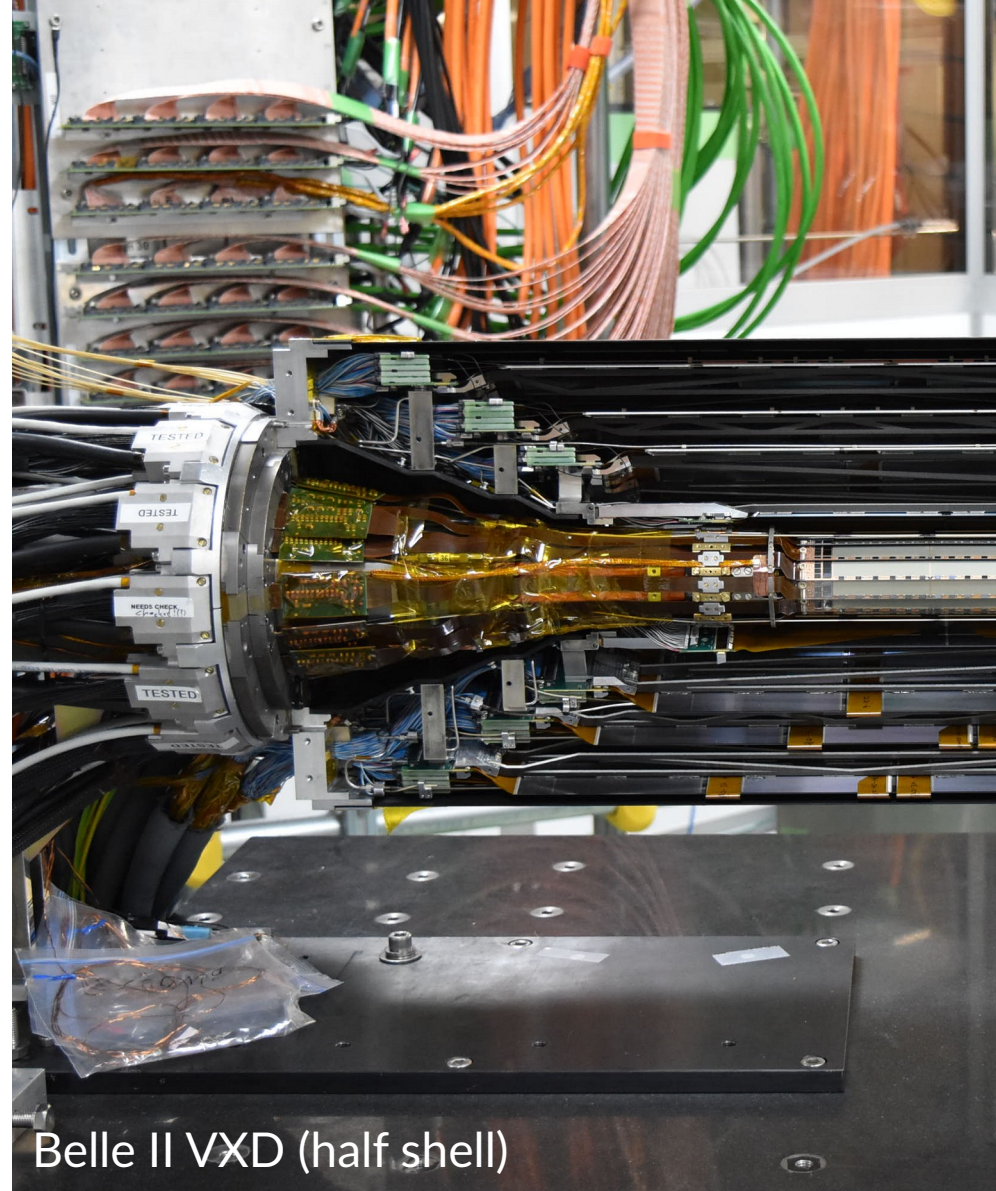
Cluster time - CDC Event Time L3 u/P side



Cluster time - CDC Event Time L3 v/N side



SVD Hit Time Applications

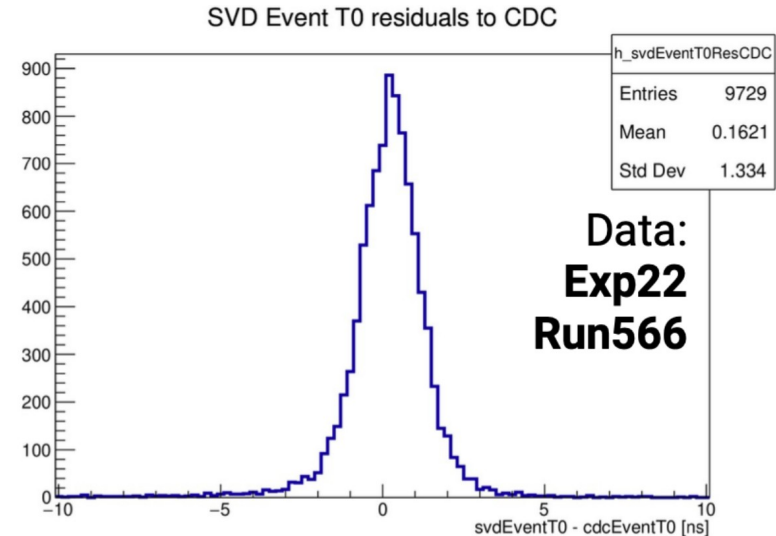


Belle II VXD (half shell)

Event Time with SVD

- **Event time (EventT0):** time of the collision w.r.t. to the arrival of the trigger signal
- **EventT0 is used to reduce the impact of beam background in the reconstruction**
 - In a quasi-continuous machine, background hit time distribution is flat, while the signal hit time distribution of peaks around EventT0
 - Average of cluster times associated to tracks with $p_T > 250$ MeV/c
- **SVD EventT0 performance is excellent**
 - Similar resolution $\sigma(1\text{ns})$ to CDC on **hadronic data**
 - Higher efficiency than CDC ($>98.5\%$), especially in low-multiplicity events
 - TOP has a better resolution, but a much lower efficiency

$$t_0^{\text{SVD}} = \frac{1}{N_{\text{cls}}} \sum_{i=1}^{N_{\text{cls}}} t_i^{\text{cls}}$$



SVD EventT0 $\sigma(1000)$ times faster
computation time w.r.t. the CDC EventT0

→ Speed up online reconstruction

Track time with SVD

Fake rate: tracks reconstructed with hits from beam-induced background or originating from wrong combinations of hits

- Average of the time of SVD hits associated to tracks referred to EventT0

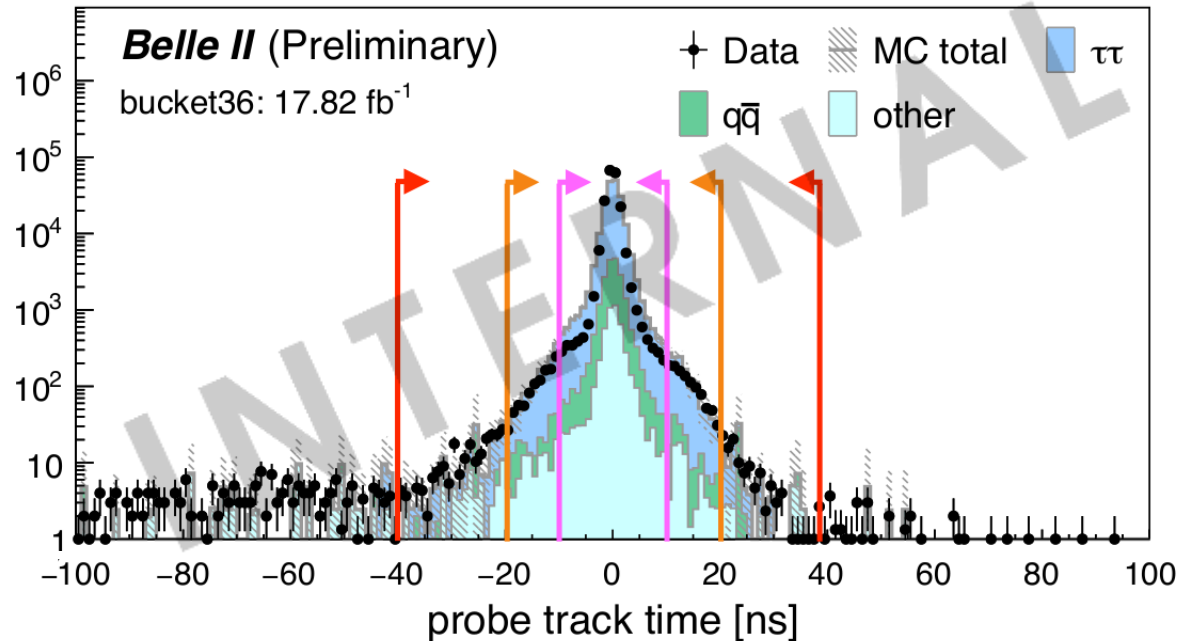
$$t_{\text{track}} = \frac{1}{N_{\text{cls}}} \sum_{i=1}^{N_{\text{cls}}} t_i^{\text{cls}} - t_0^{\text{SVD}}$$

- Can be used for background rejection. From preliminary studies, cutting at 20 ns wi

→ Almost no impact on tracking efficiency in data

→ Fake rate by a factor 1.5 on high-background data

- Provide track time to analysts to reject background



Hit time selections

- In high-background conditions, tracking will suffer due to high fake rate

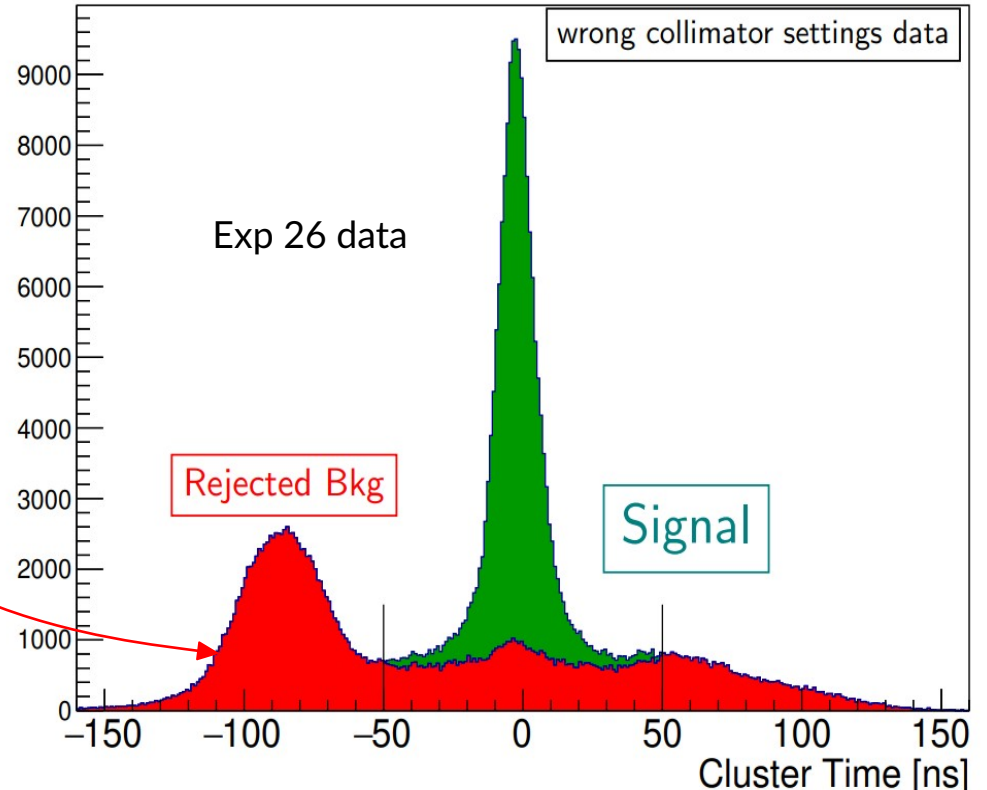
→ Reject off-time tracks is crucial

SVD Time Cuts

$$\begin{aligned} |t| &< 50 \text{ ns} \\ |t_U - t_V| &< 20 \text{ ns} \end{aligned}$$

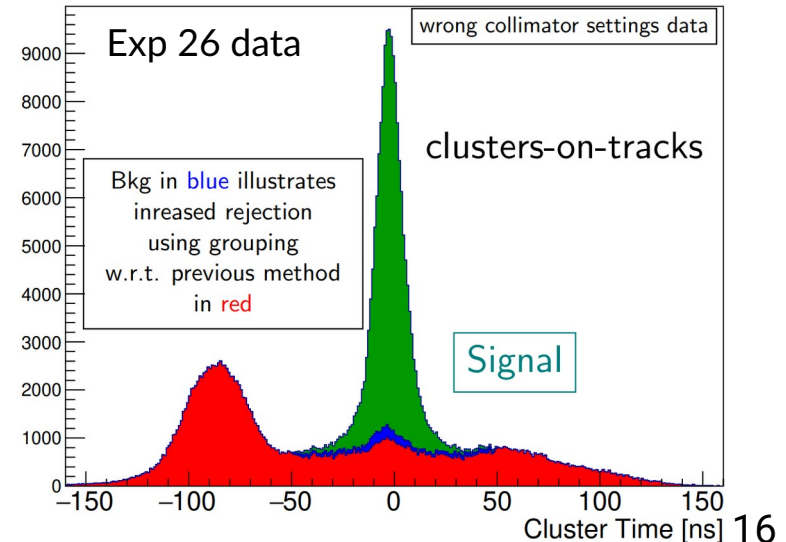
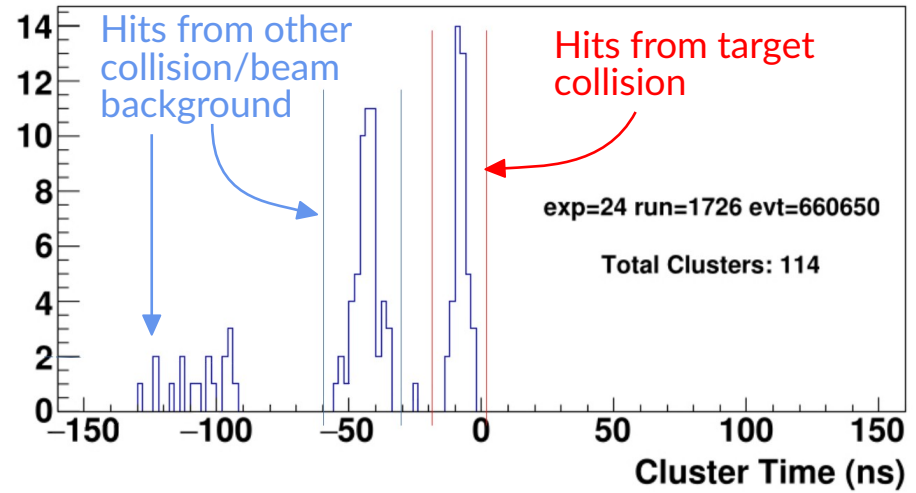
- At nominal luminosity background, **without any SVD-time based selections** the SVD occupancy limit for tracking is 3%
- Applying the **SVD-time based selection** the SVD occupancy limit for tracking is 4.7%

SVD hit-time: clusters-on-tracks



SVD hit-time grouping

- Further decrease of fake rate will come from SVD cluster-time grouping and selection based on “track time”
- Grouping
 - Exploit SVD hit-time to implement a event-by-event classification of groups of hits (clusters)
 - Clusters belonging to tracks coming from the same collision belong to the same group
 - The other ones are probably from tracks from different collisions/beam background
- **Selection on track-time to remove off-time tracks**
 - Further reduce the fake rate by a factor 1.5 on high-background data (from preliminary studies)
- **The limit of 5% occupancy can be further increased to ~6%**



Summary and conclusions

SVD is the Silicon Strip Detector of the VXD

- One of the **tracking system** detectors (PXD, SVD, CDC)
- Several functions: standalone **tracking** and **particle identification of low p_T tracks, extrapolate tracks to PXD**
- It can do more than what was designed for
→ **excellent performance of SVD Hit Time**
 - **SVD Event Time estimation** → similar resolution (1 ns), higher efficiency, much faster execution time w.r.t. CDC
 - **Track Time** → interesting tool to reduce fake rate
 - **Hit time selections** → reduce fake rate significantly

Belle II SVD paper: [JINST, 17, 2022](#)



Belle II VXD (half shell)